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ON Semiconductor®

## FQT1N80TF-WS

### N-Channel QFET® MOSFET

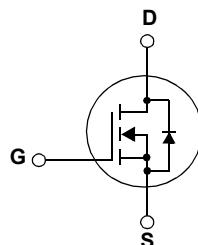
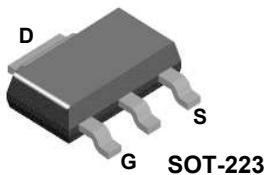
800V, 0.2 A, 20 Ω

#### Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### Features

- 0.2 A, 800 V,  $R_{DS(on)}=15.5\ \Omega$ (Typ.)@ $V_{GS}=10\ V$ ,  $I_D=0.1\ A$
- Low Gate Charge (Typ. 5.5 nC)
- Low  $C_{rss}$  (Typ. 2.7 pF)
- 100% Avalanche Tested
- RoHS Compliant



#### MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted\*

| Symbol         | Parameter   |   | FQT1N80TF-WS | Unit                      |
|----------------|---|---|--------------|---------------------------|
| $V_{DSS}$      | Drain to Source Voltage   |   | 800          | V                         |
| $V_{GSS}$      | Gate to Source Voltage  |   | $\pm 30$     | V                         |
| $I_D$          | Drain Current   | -Continuous ( $T_C = 25^\circ\text{C}$ )  | 0.2          | A                         |
|                |   | -Continuous ( $T_C = 100^\circ\text{C}$ ) | 0.12         |                           |
| $I_{DM}$       | Drain Current   | - Pulsed                                  | (Note 1)     | A                         |
| $E_{AS}$       | Single Pulsed Avalanche Energy  |   | (Note 2)     | mJ                        |
| $I_{AR}$       | Avalanche Current   |   | (Note 1)     | A                         |
| $E_{AR}$       | Repetitive Avalanche Energy   |   | (Note 1)     | mJ                        |
| $dv/dt$        | Peak Diode Recovery $dv/dt$   |   | (Note 3)     | V/ns                      |
| $P_D$          | Power Dissipation   | ( $T_C = 25^\circ\text{C}$ )              | 2.1          | W                         |
|                |   | - Derate above $25^\circ\text{C}$         | 0.02         | $\text{W}/^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range   |   | -55 to +150  | $^\circ\text{C}$          |
| $T_L$          | Maximum Lead Temperature for Soldering Purpose,<br>1/8" from Case for 5 Seconds |   | 300          | $^\circ\text{C}$          |

#### Thermal Characteristics

| Symbol          | Parameter                                | Min. | Max. | Unit                      |
|-----------------|--|------|------|---------------------------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient* | -    | 60   | $^\circ\text{C}/\text{W}$ |

\* When mounted on the minimum pad size recommended (PCB Mount)

## Package Marking and Ordering Information $T_C = 25^\circ\text{C}$ unless otherwise noted

| Device Marking | Device       | Package | Reel Size | Tape Width | Quantity |
|----------------|--------------|---------|-----------|------------|----------|
| FQT1N80        | FQT1N80TF-WS | SOT-223 | 330mm     | 12mm       | 4000     |

## Electrical Characteristics

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|-----------------|------|------|------|------|
|--------|-----------|-----------------|------|------|------|------|

### Off Characteristics

|  |   |  |     |     |           |                  |
|--|---|--|-----|-----|-----------|------------------|
| $\text{BV}_{\text{DSS}}$                     | Drain to Source Breakdown Voltage         | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$ | 800 | -   | -         | V                |
| $\Delta \text{BV}_{\text{DSS}} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu\text{A}, \text{Referenced to } 25^\circ\text{C}$     | -   | 0.8 | -         | $^\circ\text{C}$ |
| $I_{\text{DSS}}$                             | Zero Gate Voltage Drain Current           | $V_{DS} = 800\text{V}, V_{GS} = 0\text{V}$                         | -   | -   | 25        | $\mu\text{A}$    |
|  |   | $V_{DS} = 640\text{V}, T_C = 125^\circ\text{C}$                    | -   | -   | 250       |                  |
| $I_{\text{GSS}}$                             | Gate to Body Leakage Current              | $V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$                      | -   | -   | $\pm 100$ | nA               |

### On Characteristics

|                     |                                      |   |     |      |     |          |
|---------------------|--------------------------------------|---|-----|------|-----|----------|
| $V_{GS(\text{th})}$ | Gate Threshold Voltage               | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$           | 3.0 | -    | 5.0 | V        |
| $R_{DS(\text{on})}$ | Static Drain to Source On Resistance | $V_{GS} = 10\text{V}, I_D = 0.1\text{A}$          | -   | 15.5 | 20  | $\Omega$ |
| $g_{FS}$            | Forward Transconductance             | $V_{DS} = 40\text{V}, I_D = 0.1\text{A}$ (Note 4) | -   | 0.75 | -   | S        |

### Dynamic Characteristics

|           |                               |  |             |     |     |    |
|-----------|-------------------------------|--|-------------|-----|-----|----|
| $C_{iss}$ | Input Capacitance             | $V_{DS} = 25\text{V}, V_{GS} = 0\text{V}$<br>$f = 1\text{MHz}$   | -           | 150 | 195 | pF |
| $C_{oss}$ | Output Capacitance            |  | -           | 20  | 30  | pF |
| $C_{rss}$ | Reverse Transfer Capacitance  |  | -           | 2.7 | 5.0 | pF |
| $Q_g$     | Total Gate Charge at 10V      | $V_{DS} = 640\text{V}, I_D = 1\text{A}$<br>$V_{GS} = 10\text{V}$ | -           | 5.5 | 7.2 | nC |
| $Q_{gs}$  | Gate to Source Gate Charge    |  | -           | 1.1 | -   | nC |
| $Q_{gd}$  | Gate to Drain "Miller" Charge |  | (Note 4, 5) | -   | 3.3 | -  |

### Switching Characteristics

|              |                     |   |             |    |    |    |
|--------------|---------------------|---|-------------|----|----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 400\text{V}, I_D = 1\text{A}$<br>$R_G = 25\Omega$ | -           | 10 | 30 | ns |
| $t_r$        | Turn-On Rise Time   |   | -           | 25 | 60 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |   | -           | 15 | 40 | ns |
| $t_f$        | Turn-Off Fall Time  |   | (Note 4, 5) | -  | 25 | 60 |

### Drain-Source Diode Characteristics

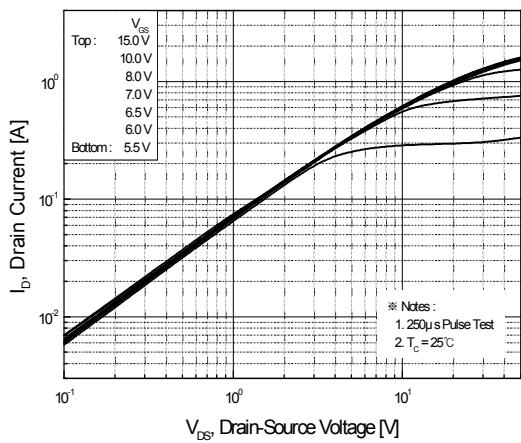
|          |  |   |          |     |     |               |
|----------|--|---|----------|-----|-----|---------------|
| $I_S$    | Maximum Continuous Drain to Source Diode Forward Current | -   | -        | 0.2 | A   |               |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current     | -   | -        | 0.8 | A   |               |
| $V_{SD}$ | Drain to Source Diode Forward Voltage                    | $V_{GS} = 0\text{V}, I_{SD} = 0.2\text{A}$                                      | -        | -   | 1.4 | V             |
| $t_{rr}$ | Reverse Recovery Time                                    | $V_{GS} = 0\text{V}, I_{SD} = 1\text{A}$<br>$dI_F/dt = 100\text{A}/\mu\text{s}$ | -        | 300 | -   | ns            |
| $Q_{rr}$ | Reverse Recovery Charge                                  |   | (Note 4) | -   | 0.6 | $\mu\text{C}$ |

Notes:

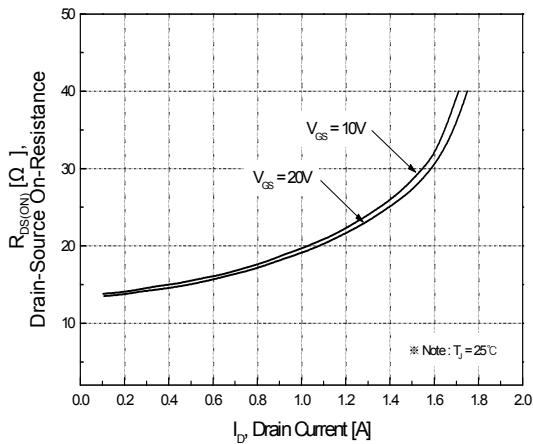
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $L = 170\text{mH}, I_{AS} = 1\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega, \text{Starting } T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 1\text{A}, dI/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq BV_{DSS}, \text{Starting } T_J = 25^\circ\text{C}$
4. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

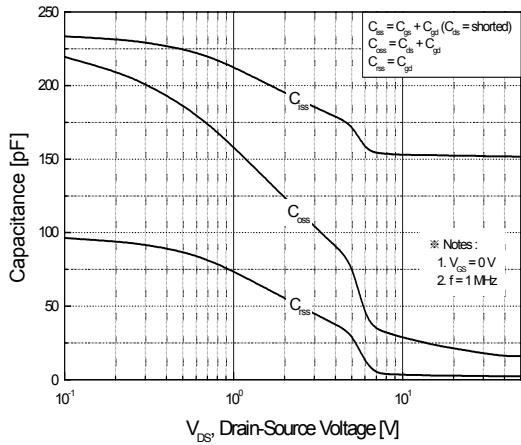
**Figure 1. On-Region Characteristics**



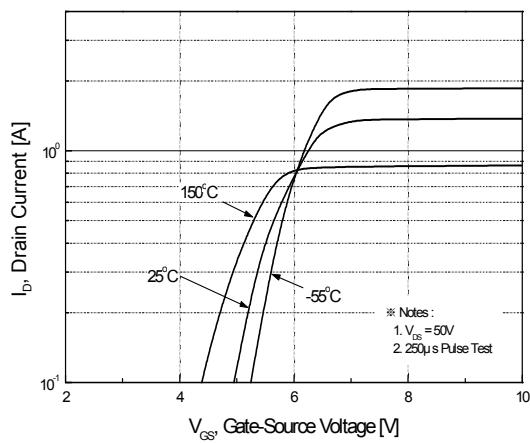
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



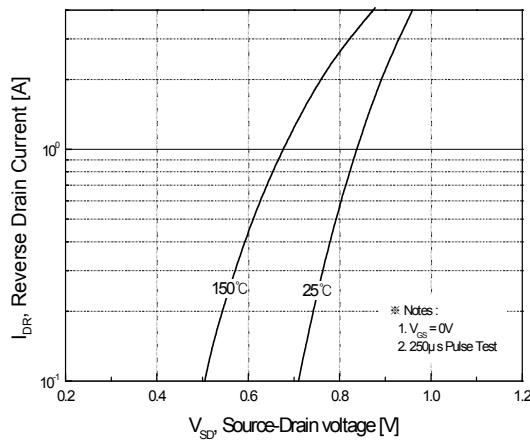
**Figure 5. Capacitance Characteristics**



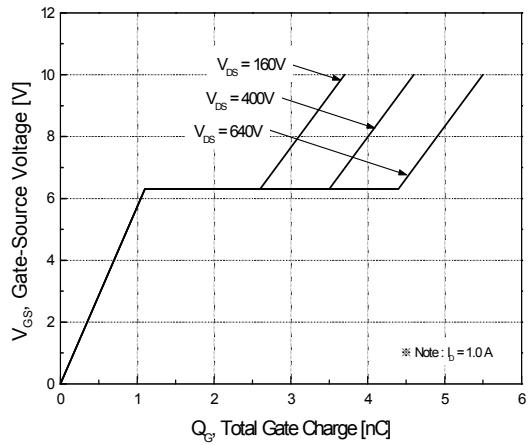
**Figure 2. Transfer Characteristics**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

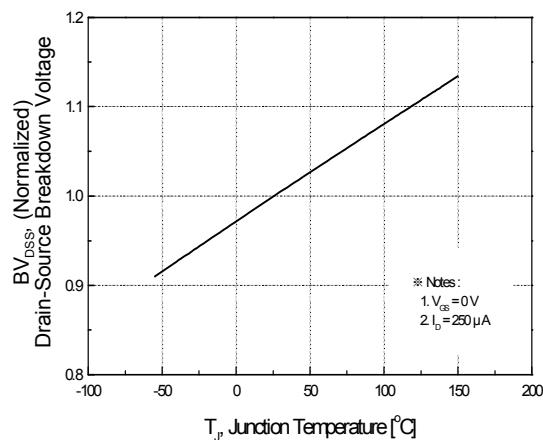


**Figure 6. Gate Charge Characteristics**

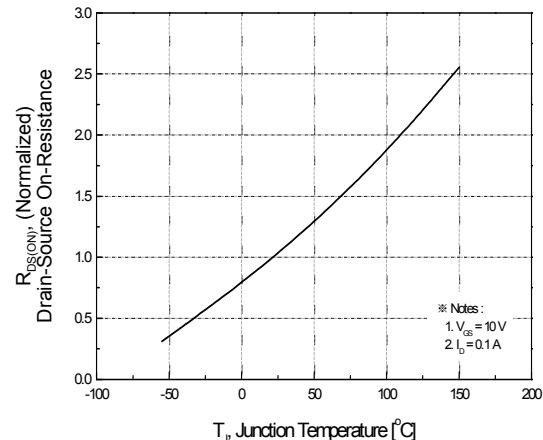


## Typical Performance Characteristics (Continued)

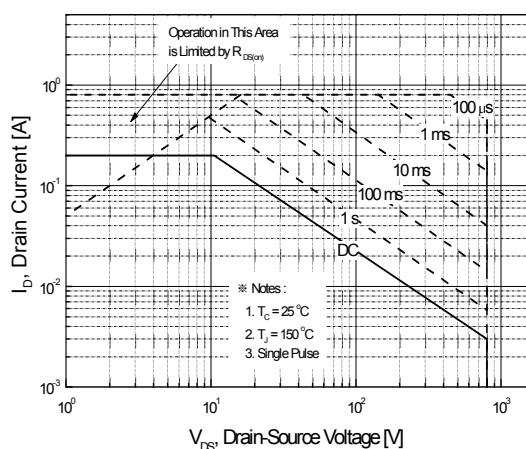
**Figure 7. Breakdown Voltage Variation vs. Temperature**



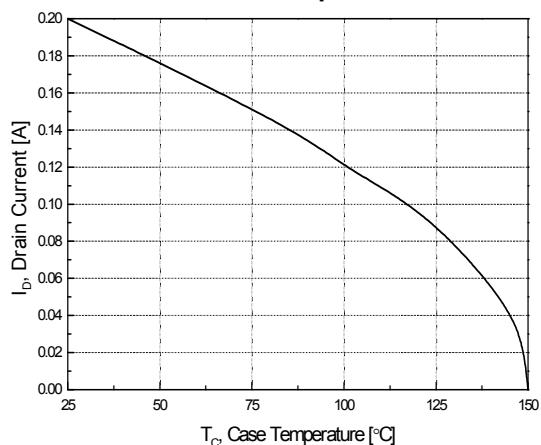
**Figure 8. On-Resistance Variation vs. Temperature**



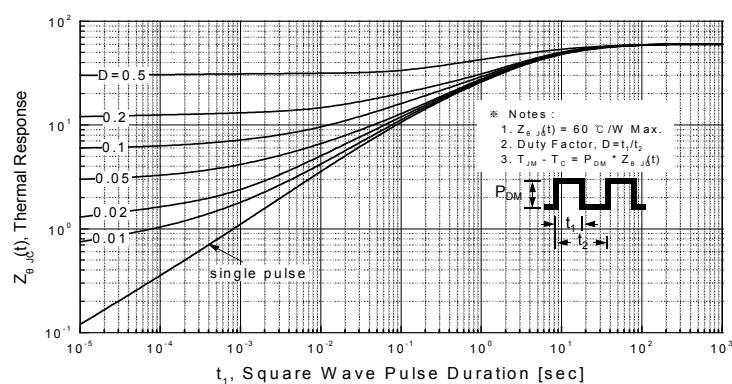
**Figure 9. Maximum Safe Operating Area**



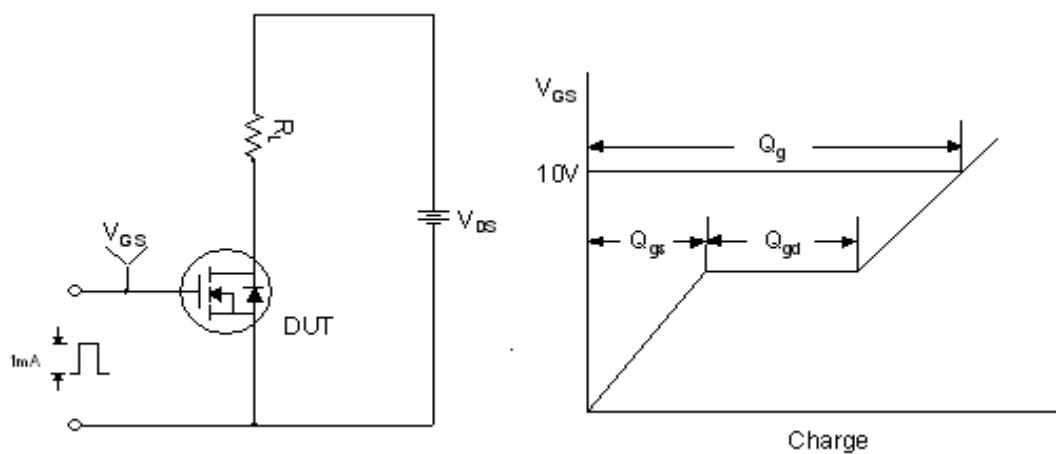
**Figure 10. Maximum Drain Current vs. Case Temperature**



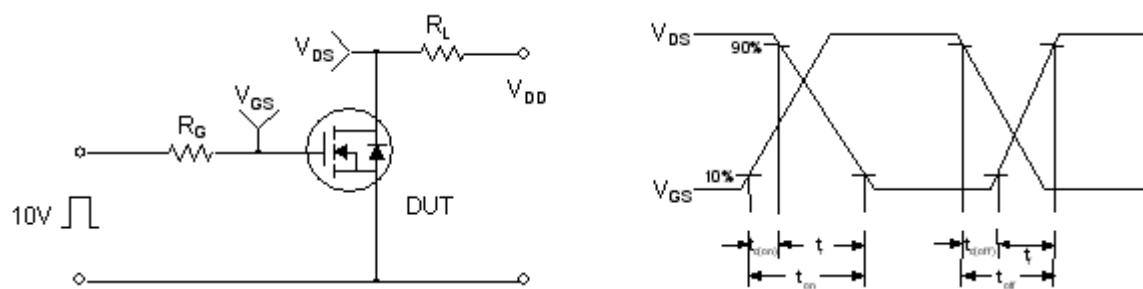
**Figure 11. Transient Thermal Response Curve**



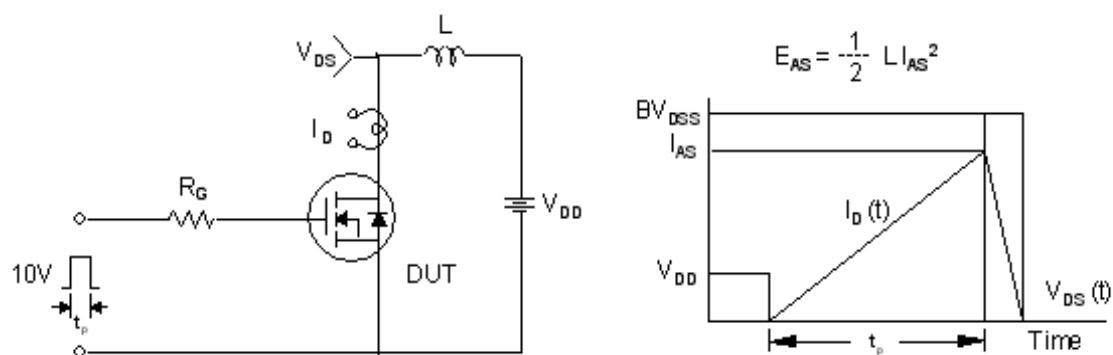
**Gate Charge Test Circuit & Waveform**



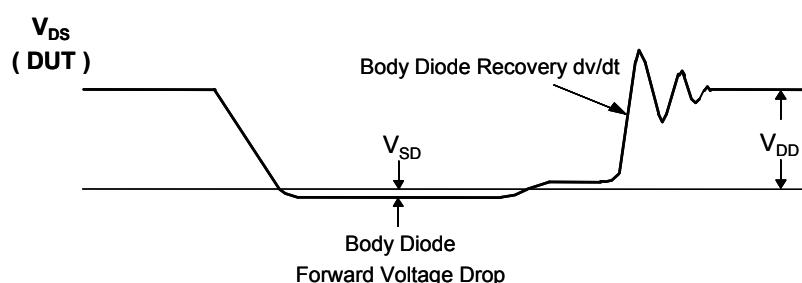
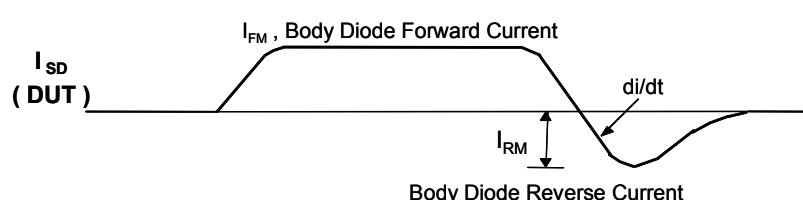
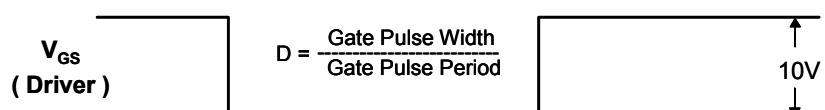
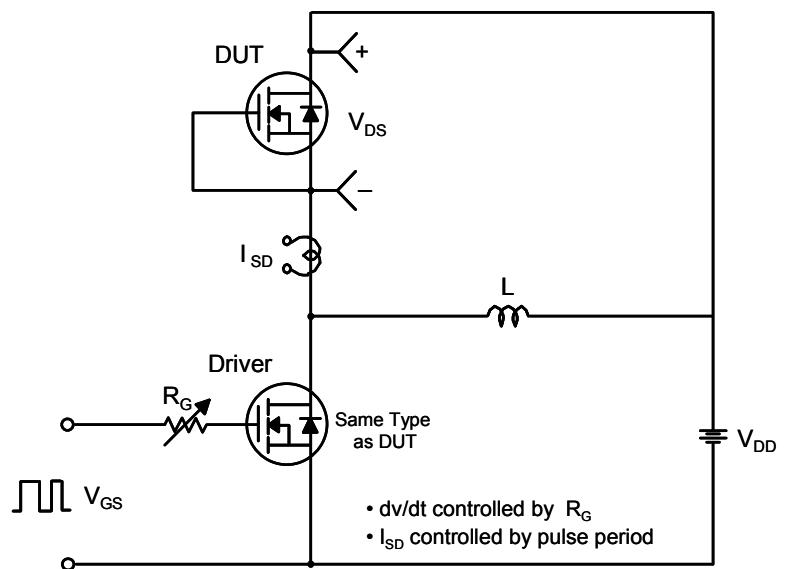
**Resistive Switching Test Circuit & Waveforms**

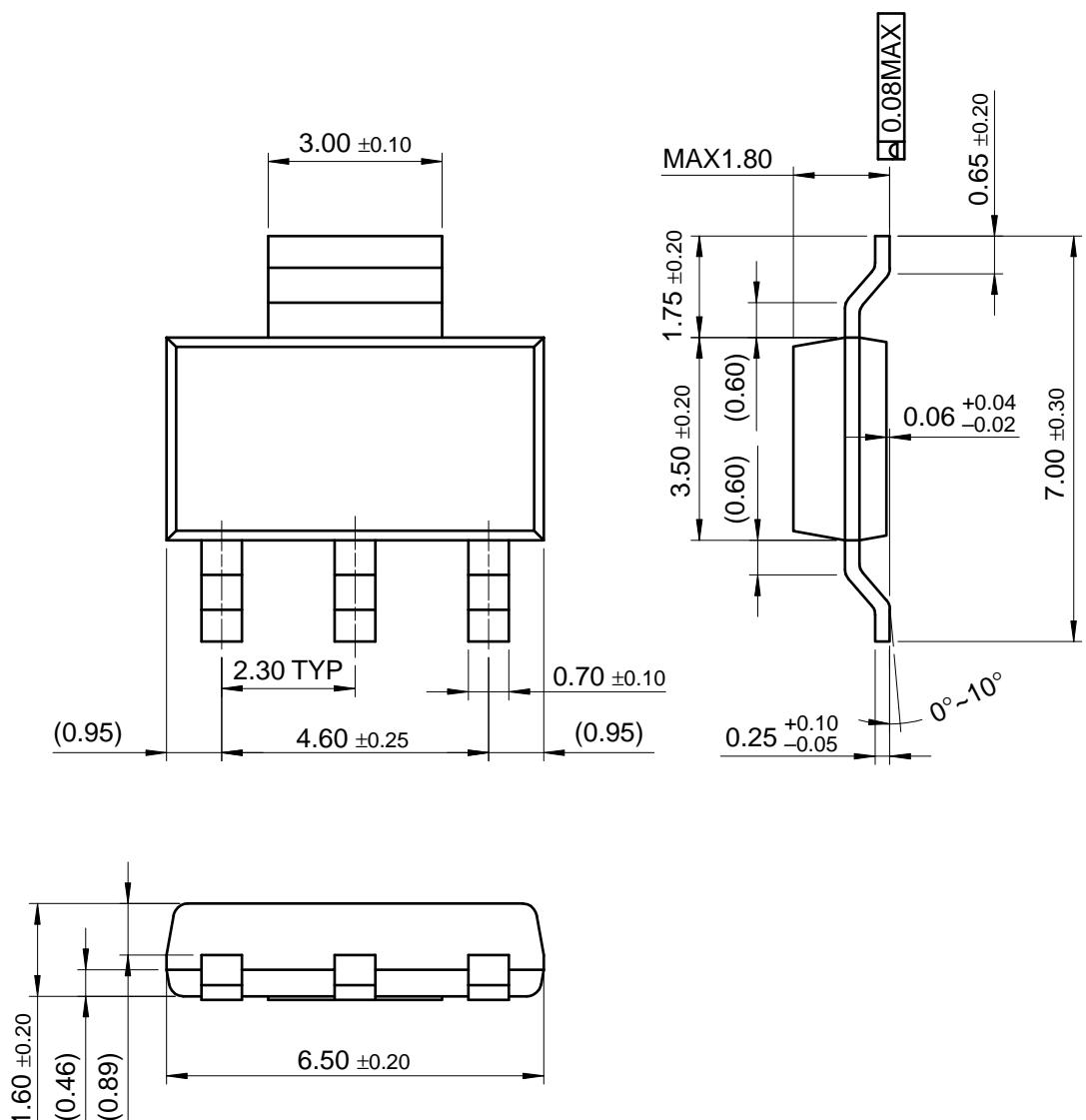


**Unclamped Inductive Switching Test Circuit & Waveforms**



**Peak Diode Recovery dv/dt Test Circuit & Waveforms**



**Mechanical Dimensions****SOT-223**

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